

Notice of References Cited	Application/Control No. 10/714,642	Applicant(s)/Patent Under Reexamination TAKENAKA ET AL.	
	Examiner Tan Le	Art Unit 3632	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,119,454	10-2006	Chiao, Sheng	307/9.1
*	B	US-2003/0106727	06-2003	Takenaka et al.	180/65.2
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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